SCLS157

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

description

These devices contain two independent 4-input positive NOR gates. They perform the Boolean functions:

 $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D} \text{ or } Y = \overline{A} \cdot \overline{B} \cdot \overline{C} \cdot \overline{D}$ in positive logic.

The SN54HC4002 is characterized for operation over the full military temperature range of $-55\,^{\circ}$ C to $125\,^{\circ}$ C. The SN74HC4002 is characterized for operation from $-40\,^{\circ}$ C to $85\,^{\circ}$ C.

FUNCTION TABLE

	INP	OUTPUT		
A	B	С	D	Y
н	Х	Х	Х	L
х	н	х	х	L
х	Х	н	х	ί ι
х	х	х	н	L
L	L	L	L	н

logic symbol[†]



[†]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, and N packages.

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10 28

9 🗌 2 A

8 NC

	AL
	J PACKAGE D OR N PACKAGE
TOP	VIEW)
1.0.	
1Y [] I	
1A 🗌 2	13 🗋 2 Y
1B 🛄 3	12 🗋 2 D
1C 🚺 4	11 🗋 2C

SN54HC4002	FK PACKAGE
(TOP	VIEW)

1D 🗍 5

NC 6

GND 7

~		<u>, </u>
1B]4 NC]5 1C]6 NC]7 1D]8	5 2 1 20 1	18 2D 17 NC 16 2C 15 NC 14 28
L	9 10 11 12 12 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0 0	i

NC-No internal connection

logic diagram (positive logic)



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SN54HC4002, SN74HC4002 DUAL 4-INPUT POSITIVE-NOR GATES

absolute maximum ratings over operating free-air temperature range[†]

Supply voltage range, VCC
Input clamp current, I _K (VI < 0 or VI > VCC) $\dots \dots \dots$
Output clamp current, I_{OK} (VO < 0 or VO > VCC) ±20 mA
Continuous output current, IO (VO = 0 to VCC) ±25 mA
Continuous current through VCC or GND pins ±50 mA
Lead temperature 1,6 mm (1/16 in) from case for 60 s: FK or J package
Lead temperature 1,6 mm (1/16 in) from case for 10 s: D or N package
Storage temperature range

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

			SN54HC4002			SN74HC4002			
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		2	5	6	2	5	6	V
		V _{CC} = 2 V	1.5			1.5			
VIH High-level input voltage	High-level input voltage	$V_{CC} = 4.5 V$	3.15			3.15		i	V
		$V_{CC} = 6 V$	4.2			4.2			
		V _{CC} = 2 V	0		0.3	0		0.3	
VIL	Low-level input voltage	$V_{CC} = 4.5 V$	0		0.9	0		0.9	V
		$V_{CC} = 6 V$	0		1.2	0		1.2	
VI	Input voltage		0		Vcc	0		Vcc	V
Vo	Output voltage		0		Vcc_	0		Vcc	V
tt Input transition (rise and fall) time		V _{CC} = 2 V	0		1000	0		1000	
	Input transition (rise and fall) times	$V_{CC} = 4.5 V$	0		500	0		500	ns
-		$V_{CC} = 6 V$	0		400	0		400	
ΤA	Operating free-air temperature		- 55		125	- 40		85	°C

recommended operating conditions

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

			TA = 25°C			SN54HC4002		SN74HC4002		UNIT
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
		2 V	1.9	1.998		1.9		1.9	I	
	$V_{I} = V_{IH}$ or V_{IL} , $I_{OH} = -20 \ \mu A$	4.5 V	4.4	4.499		4.4		4.4		
∨он		6 V	5.9	5.999		5.9	_	5.9		v
	$V_{I} = V_{IH} \text{ or } V_{IL}, I_{OH} = -4 \text{ mA}$	4.5 V	3.98	4.30		3.7		3.84		
-	$V_{ } = V_{ }$ or $V_{ }$, $I_{O } = -5.2 \text{ mA}$	6 V	5.48	5.80		5.2		5.34		
	$V_{I} = V_{IH}$ or V_{IL} , $I_{OL} = 20 \ \mu A$	2 V		0.002	0.1		0.1		0.1	v
		4.5 V		0.001	0.1		0.1		0.1	
VoL		6 V		0.001	0.1]	0.1		0.1	
	$V_{ } = V_{ }$ or $V_{ L}$, $I_{OL} = 4 \text{ mA}$	4.5 V		0.17	0.26		0.4		0.33	
F	VI = VIH or VIL, IOL = 5.2 mA	6 V		0.15	0.26	-	0.4		0.33	
	$V_{\rm I} = V_{\rm CC} \text{ or } 0$	6 V		±0.1	±100		±1000	1	± 1000	nA
lcc	$V_{I} = V_{CC} \text{ or } 0, I_{O} = 0$	6 V			2		40		20	μA
C _i		2 to 6 V		3	10	1 -	10		10	рF



SN54HC4002, SN74HC4002 DUAL 4-INPUT POSITIVE-NOR GATES

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switching characteristics over recommended operating free-air temperature range (unless otherwise noted), $C_L = 50 \text{ pF}$ (see Note 1)

PARAMETER	FROM	то	Vcc	T _A = 25°C			SN54HC4002		SN74HC4002		UNIT
	(INPUT)	(OUTPUT)		MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
^t pd	•		2 V		44	110	[165		140	
	A thru D	Y	4.5 V		12	22		33		28	ns
			6 V		11	19		28		24	
			2 V		38	75		110		95	
tt		Y	4.5 V		8	15		22		19	กร
-			6 V	1	6	13		19		16	
· ·				·					L		
Cpd	Power dissipation capacitance per gate				No load	i, T _A =	25°C		2	5 pF typ	

Note 1: Load circuits and voltage waveforms are shown in Section 1.



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